

Notice of References Cited	Application/Control No. 09/455,964	Applicant(s)/Patent Under Reexamination QIAN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,177,931	01-2001	Alexander et al.	345/327
	B	US-6,002,394	12-1999	Schein et al.	345/327
	C	US-6,240,555	05-2001	Shoff et al.	725/110
	D	US-6,236,395	05-2001	Sezan et al.	345/328
	E	US-6,111,614	08-2000	Mugura et al.	348/569
	F	US-6,268,849	07-2001	Boyer et al.	345/327
	G	US-5,907,323	05-1999	Lawler et al.	345/327
	H	US-6,005,565	12-1999	Legall et al.	345/327
	I	US-6,351,270	02-2002	Nishikawa et al.	345/717
	J	US-6,536,041	03-2003	Knudson et al.	725/39
	K	US-5,929,849	07-1999	Kikinis	345/327
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 848 554 A2	06-1998		Dodson et al.	H04N 7/173
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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